CHART O

OBSERVATIONS ON THE SP-100 PROGRAM

SP-100 THERMOELECTRIC CONVERTER

AM CONFIDENT THAT LARGE SPACE POWER SYSTEMS CAN WORK AND ARE AN INEVITABLE PART OF LARGE-SCALE UTILIZATION OF SPACE

AM CONCERNED THAT THE SP-100 PROGRAM, AS CURRENTLY CONFIGURED, WILL NOT BE AN EFFECTIVE TOOL TO REALIZE THAT GOAL

WILL TRY TO TELL YOU WHY I FEEL THIS WAY

- INTRODUCTION
- 000 BACKGROUND
- SP-100 TECHNICAL ISSUES

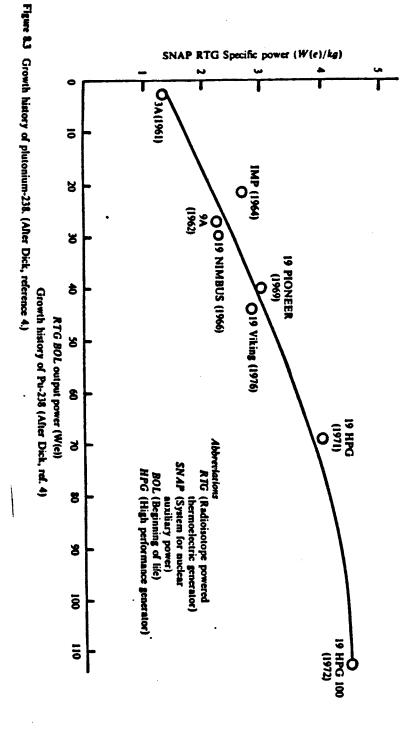
BULK MATERIALS ISSUES JOINING ISSUES

SUMMARY

0 0

APPENDIX: EXECUTIVE SUMMARY

							HEAT SOURCE: CONVERSION DEVICE:	
1.1 meters	5.4 W/kg	56 kg	28 V	5. 8 ×	0.3 kW	4. 4 KW	Plutonium-238 UNICOUPLES	FLIGHT RTG's
12 meters	30 W/kg	10,000 kg	200 V	4. 4 ×	300 kW	6,800 kW	Fast Reactor	SP-100
11	5. 5	178	7	0.65	1000	1500		SCALE FACTOR



RTG SUCCESSES HAVE GIVEN THERMOELECTRICS A REPUTATION FOR RELIABILITY

REQUIRE A REACTOR

SNAP-10A IS THE ONLY PREVIOUS REACTOR FLOWN BY PRODUCED ABOUT 500 W OF ELECTRICAL OUTPUT THE US (1965)

SP-100 SPECIFIC POWER NEEDS (30 W/kg)

CUSTOMER SATISFACTION

NASA-JPL HAS RESPONSIBILITY FOR U.S. SPACE CAPABILITIES DOE HAS RESPONSIBILITY FOR U.S. NUCLEAR CAPABILITIES

THERMOELECTRICS ARE NEITHER "SPACE" NOR "NUCLEAR" BOTH SEEM TO SEEK OWNERSHIP OF THERMOELECTRIC TECHNOLOGY

THERMOELECTRIC TECHNOLOGY IS CENTRAL TO BOTH FAMILIES OF PROGRAMS SP-100 FAMILY - GERRY STAPFER (NASA-JPL) GROUND ENGINEERING SYSTEM

GE - PRIME

COMPLIANT PAD TECHNOLOGY CONTRACT GENERAL ATOMICS, RASOR - PLANNED SUBCONTRACTORS TECO, WESTINGHOUSE - SUBCONTRACTORS

GE - PRIME

TECO - SUBCONTRACTOR

SiGe/GaP DEVELOPMENT CONTRACT

TECO - PRIME

- GE -SUBCONTRACTOR
- Ņ RTG FAMILY - JIM LOMBARDO (DOE-GERMANTOWN) IMPROVED THERMOELECTRIC MATERIALS (ITM) MODULAR RADIOISOTOPE THERMOELECTRIC GENERATOR (MOD-RTG) GENERAL PURPOSE HEAT SOURCE (GPHS) - GALLILEO FLIGHT PROGRAM
- DIPS JIM LOMBARDO (DOE-GERMANTOWN) PROPOSAL EFFORTS

PERFORMANCE ON RTG PROGRAMS IMPACT SP-100, AND VICE-VERSA PERFORMANCE IMPROVEMENTS ENHANCE RTG'S, WHICH ALREADY WORK SP-100 NEEDS PERFORMANCE IMPROVEMENTS TO REMAIN COMPETITIVE SP-100 NEEDS CLOSE-PACKED DEVICES RTG'S ONLY WANT THEM

COMBINED PERFORMANCE ON SP-100 AND RTG'S COULD IMPACT WINNING DIPS IF GE HAS TROUBLE JUGGLING SP-100 AND RTG'S, THEN HOW CAN GE ABSORB DIPS?

OTHER BACKGROUND

COMPETITION WITH ALTERNATE CONVERSION SYSTEMS THERMIONICS, TO COUNTER COMPETITION, SP-100 HAS TAKEN AN AGGRESSIVE APPROACH THERMOELECTRICS ARE EXPECTED TO WORK BASED ON HISTORY CURRENT DESIGN CONCEPTS ARE MORE AGGRESSIVE AND RISKY AND HAVE BEEN SOLD AS RELIABLE OFFERED GREATER GROWTH POTENTIAL STIRLING ETC, REQUIRE MORE DEVELOPMENT

CATASTROPHIC FAILURE HAS STRUCK BEFORE (LANTHANUM SULFIDE, ONCE THE PRIME CANDIDATE "SELENIDE" HAS BECOME A SYNONYM FOR FAILURE 3M NO LONGER WORKS ON THERMOELECTRICS PROGRAM CANCELLED WHEN GES FAILED DUE TO INTRINSIC WEAKNESSES SELENIDES PROGRAM WAS INITIATED AT 3M BASED UPON NEW MATERIALS IN EARLY 1970's SiGe/UNICOUPLE TECHNOLOGY SHUT DOWN AT RCA PRACTICALLY IDENTICAL TO THE SELENIDES) FOR SP-100, IS

SPECIALIZED TECHNOLOGY

NOT THAT MANY EXPERTS EXIST

WIDE VARIETY OF SUBTLE AND COMPLEX PROBLEMS

HAS NO IDENTIFIED MISSION

CURRENT PERFORMANCE GOALS ARE ALMOST CERTAINLY UNREASONABLE LOWER GOALS DECREASES TECHNICAL RISK, INCREASES POLITICAL RISK

CHART #6

SP-100 KEY TECHNICAL ISSUES

OUTSIDE CONVERTER SUBSYSTEM

FUEL ELEMENT LIFE

COMPATIBILITY OF FUEL, LINER AND CLADDING

LITHIUM THAW

REQUIRES A THERMOELECTRIC CELL WHICH IS IN SOME WAYS MORE

TEM PUMP PERFORMANCE

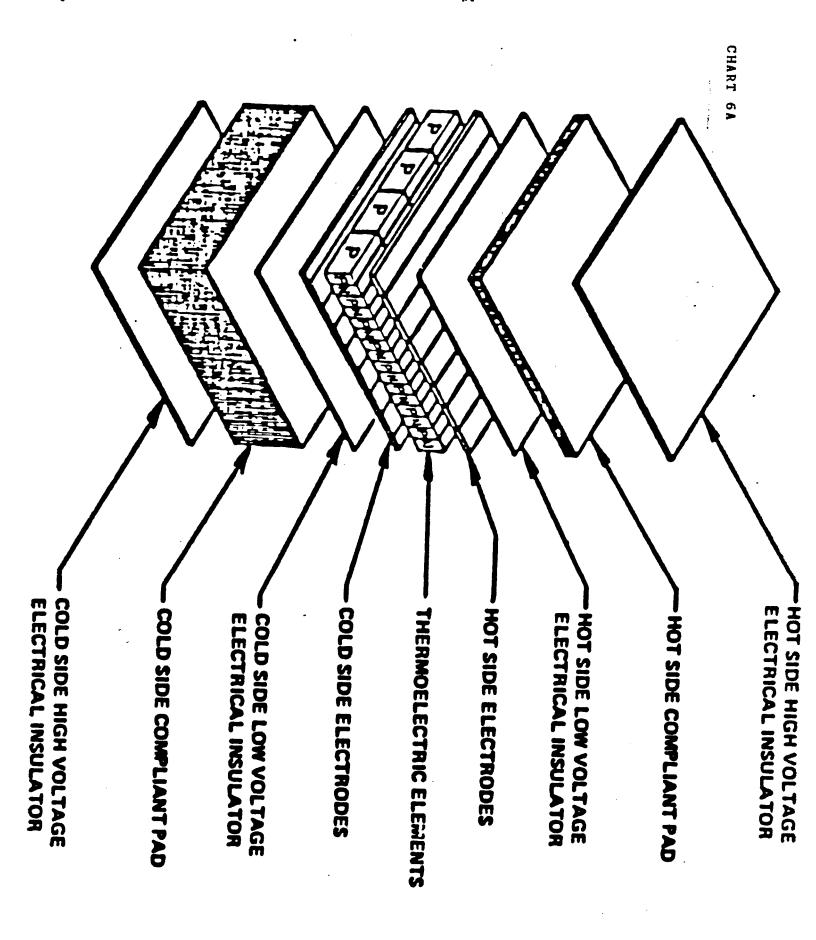
DEMANDING THAN THE CONVERTER CELLS SINCE THE COMPLIANT PADS

DEPLOYABLE RADIATOR ARE IN THE ELECTRICAL PATH

HEAT PIPE TRANSIENT

CONVERTER PRODUCTION HIGH VOLUME/LOW COST

SAFETY SAFETY SAFETY



THERMOELECTRIC CELL TECHNICAL ISSUES

JOINING OF INSULATOR TO HOT SIDE COMPLIANT PAD JOINING OF COMPLIANT PAD HOT SIDE LOW VOLTAGE ELE JOINING OF LOW VOLTAGE IN HOT SIDE ELECTRODE MATER CONTACT RESISTANCE/JOINI CONTACT RESISTANCE/JOINI CONTACT RESISTANCE/JOINI COLD SIDE ELECTRODE MATER JOINING OF ELECTRICAL JOINING OF ELECTRODE IN JOINING OF LOW VOLTAGE IN JOINING OF LOW VOLTAGE IN COMPLIANT PAD, COLD SIDE
SIDE HIGH VOLTAGE IN NING OF INSULATOR TO SIDE COMPLIANT PAD NING OF COMPLIANT PAD SIDE LOW VOLTAGE ELE NING OF LOW VOLTAGE I SIDE ELECTRODE MATER TACT RESISTANCE/JOINI RMOELECTRIC MATERIALS SSING TACT RESISTANCE/JOINI D SIDE ELECTRODE MATE L TO CELL ELECTRODE TO D SIDE LOW VOLTAGE IN D SIDE LOW VOLTAGE IN D SIDE LOW VOLTAGE IN
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HOT SIDE HIGH VOLTAGE IN JOINING OF INSULATOR TO HOT SIDE COMPLIANT PAD
HOT SIDE HIGH VOLTAGE IN JOINING OF INSULATOR TO
HOT SIDE HIGH VOLT

CHART #7

FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE REQUIREMENTS: ISSUE #1: JOINING OF PRIMARY HEAT LOOP TO HOT SIDE ELECTRICAL INSULATOR

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS

SUFFICIENT MECHANICAL STRENGTH

IMPACT: CHEMICAL COMPATIBILITY WITH INSULATOR AND Nb1Zr

STATUS: CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

MAY REQUIRE "GRADED SEAL" EXPECT TO REQUIRE METALIZED INSULATOR CONCERN ABOUT USING NOBLE-METAL BRAZES

HIGH CONFIDENCE APPROACH NOT YET DEMONSTRATED

ISSUE #2: HOT SIDE HIGH VOLTAGE INSULATOR STABILITY

FUNCTION: ELECTRICALLY ISOLATE EACH CELL FROM COMMON STRUCTURAL ELEMENTS REQUIREMENTS:

THERMAL EXPANSION MATCH

HIGH ELECTRICAL RESISTIVITY (R) TO MINIMIZE ELECTRICAL POWER LOSS HIGH THERMAL CONDUCTIVITY (K) TO MINIMIZE TEMPERATURE DROP

FIGURE OF MERIT = $R \times K$, GOAL OF 2,000,000 V^2/K

CHEMICAL COMPATIBILITY (THERMODYNAMIC)

JOINABLE TO PRIMARY HEAT LOOP AND COMPLIANT PAD STABILITY IN HIGH ELECTRIC FIELD (4000 V/cm)

STATUS:

SYSTEM PERFORMANCE IS DIRECTLY RELATED TO INSULATOR F.O.M. CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL INSULATOR

MODELS INDICATE UNMODIFIED A1203 WILL BREAKDOWN FROM IONIC LITERATURE INDICATES CHEMICAL INCOMPATIBILITY IN Li-Nb1Zr-A1203 A1203 IS PRIMARY CANDIDATE, BeO AND AIN BEING CONSIDERED MIGRATION. DATA IS SCARCE.

ACCEPTABLE INSULATOR HAS NOT BEEN DEMONSTRATED 9 MONTH, \$700,000 PROGRAM AT GENERAL ATOMICS: FEW USEFUL RESULTS

CHART #9

ISSUE \$3: JOINING OF INSULATOR TO COMPLIANT PADFUNCTION: COMPLETE THE HEAT PATH TO THE MODULE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS

SUFFICIENT MECHANICAL STRENGTH
MUST BE EFFECTED WITHOUT CRUSHING COMPLIANT PAD

IMPACT:

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

STATUS:

EXPECT TO REQUIRE METALIZED INSULATOR MAY REQUIRE "GRADED SEAL" HIGH CONFIDENCE APPROACH NOT YET DEMONSTRATED

CHART #10

ISSUE #4: HOT SIDE COMPLIANT PAD

FUNCTION: HOT SIDE INSULATOR/PRIMARY HEAT LOOP (Nb1Zr) ACCOMMODATE THERMAL EXPANSION DIFFERENCE BETWEEN MODULE AND

REQUIREMENTS:

MINIMIZE STRESSES ON THERMOELECTRIC MODULE

MECHANICAL INTEGRITY

HIGH THERMAL CONDUCTIVITY

TRANSMITS SMALL FORCES INTO THERMOELECTRIC MODULE

IMPACT:

INTERNAL CHEMICAL COMPATIBILITY
JOINABLE TO HIGH AND LOW VOLTAGE INSULATORS

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL PAD SYSTEM PERFORMANCE IS STRONGLY DRIVEN BY PAD PERFORMANCE

STATUS:

INITIAL DEVELOPMENT UNDER IRD RESULTED IN TEST MODULE POOR THERMAL PERFORMANCE

MANY FIBERS BROKEN

ACCEPTABLE PAD HAS NOT BEEN DEMONSTRATED

ISSUE #5: JOINING OF COMPLIANT PAD TO LOW VOLTAGE INSULATOR, HOT SIDE FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE SUFFICIENT MECHANICAL STRENGTH

IMPACT: MUST BE EFFECTED WITHOUT CRUSHING COMPLIANT PAD

STATUS:

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

EXPECT TO REQUIRE METALLIZATION OF LOW VOLTAGE INSULATOR HIGH CONFIDENCE APPROACH NOT YET DEMONSTRATED

CHART 12
ISSUE #6 HOT SIDE LOW VOLTAGE ELECTRICAL INSULATOR REQUIREMENTS: FUNCTION: ELECTRICALLY ISOLATE A MODULE FROM COMPLIANT PAD

THERMAL EXPANSION MATCH

HIGH ELECTRICAL RESISTIVITY (R) TO MINIMIZE ELECTRICAL POWER LO FIGURE OF MERIT = R*K, 300 V^2/K IS PROBABLY ACCEPTABLE HIGH THERMAL CONDUCTIVITY (K) TO MINIMIZE TEMPERATURE DROP

CHEMICAL COMPATIBILITY (THERMODYNAMIC)

STABILITY IN MODERATE ELECTRIC FIELD (200 V/cm)

JOINABLE TO COMPLIANT PAD AND ELECTRODES

IMPACT:

STATUS: MODULES LOSE POWER IF GLASS FAILS

EE2/EE9 GLASS IDENTIFIED

IDENTICAL GLASS USED FOR MODULE GLASSING

FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE ISSUE #7: JOINING OF LOW VOLTAGE INSULATOR TO ELECTRODE, HOT SIDE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS

SUFFICIENT MECHANICAL STRENGTH

MUST BE EFFECTED WITHOUT CRUSHING COMPLIANT PAD

IMPACT:

LOSS OF HEAT FLUX IF JOINT FAILS

STATUS:

CONCERN ABOUT REDUCTION OF OXIDES BY GRAPHITE APPLICATION TECHNOLOGY EXISTS FOR SIMO AND GRAPHITE

ISSUE #8: HOT SIDE ELECTRODE MATERIAL FUNCTION: COMPLETE THE ELECTRICAL CIRCUIT BETWEEN LEGS

REQUIREMENTS:

THERMAL EXPANSION MATCH TO SIGE

HIGH THERMAL CONDUCTIVITY

LOW ELECTRICAL RESISTIVITY

CHEMICAL COMPATIBILITY

JOINABLE TO SIGE WITH LOW SPECIFIC CONTACT RESISTANCE JOINABLE TO LOW VOLTAGE INSULATOR

IMPACT:

LESS POWER OUTPUT

STATUS

ELECTRODE PERFORMANCE IS MORE IMPORTANT TO SP-100 THAN RTG'S SHORTER LEGS MAKE ELECTRODES A LARGER FRACTION OF TOTAL LOSS EXISTING Simo TECHNOLOGY CAN BE READILY ADAPTED TO SP-100 PERFORMANCE PENALTY CONSIDERED LARGE

GRAPHITE IDENTIFIED AS ALTERNATIVE, SUPERIOR K THAN SIMO EXPERIENCE WITH GRAPHITE INDICATED FAILURES DUE TO SIC FORMATION

CONCERN ABOUT REACTION OF GRAPHITE WITH GLASS

FUNCTION: COMPLETE THE ELECTRICAL PATH TO THE THERMOELECTRICS ISSUE #9: JOINING OF ELECTRODE TO T/E MATERIALS, HOT SIDE

REQUIREMENTS:

LOW ELECTRICAL CONTACT RESISTANCE

HIGH THERMAL CONDUCTIVITY

NOT TOO HOT TO DAMAGE MATERIALS (EG. GLASS, SiGe)

SUFFICIENT MECHANICAL STRENGTH HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE

I MP ACT:

LESS POWER OUTPUT

STATUS:

EXISTING SIMO TECHNOLOGY CAN BE ADAPTED TO SP-100 CONTACT RESISTANCE IS MORE IMPORTANT TO SP-100 THAN RTG'S PERFORMANCE PENALTY NOT WELL KNOWN SHORTER LEGS MAKE ELECTRODES A LARGER FRACTION OF TOTAL LOSS

EXISTING TEST METHODS ARE INADEQUATE TO DETERMINE CONTACT RESISTANCE WITH ACCURACY REQUIRED BY SP-100

PLANS EXIST TO IMPROVE TEST METHODS

FUNCTION: DIRECT CONVERSION OF HEAT FLUX TO ELECTRICAL POWER ISSUE #10: THERMOELECTRIC MATERIALS: SiGe, SiGe/GaP OR OTHER

REQUIREMENTS:

COMBINED n-TYPE AND p-TYPE FIGURE OF MERIT OF Z=0.85 x 10⁻³/K AVERAGE FROM 550 C TO 1000 C AT END OF LIFE STABLE UNDER OPERATING CONDITIONS

IMPACT: CURRENT SYSTEM STUDIES ARE BASED ON Z=0.85 x 10-3/K SYSTEM WEIGHT IS NEARLY PROPORTIONAL TO FIGURE OF MERIT

STATUS:

COMBINED n-TYPE SiGe/GaP (JPL DATA) AND p-TYPE SiGe (GE DATA) GIVES AVERAGE Z=0.73 TO 0.83 \times 10⁻³/K RESULTS FROM THE DOE IMPROVED THERMOELECTRIC MATERIALS PROGRAM AT GE SUGGEST $Z=0.67 \times 10^{-3} / K$ IS POSSIBLE WITH Sige CURRENT SIGE HAS AN AVERAGE Z=0.61 x 10-3/K (GE DATA) VANDERSANDE (JPL) HAS REPORTED Z=1.0 TO 1.2 x 10-3/K FOR USE OF CURRENT SIGE MEANS A 25% WEIGHT OR POWER PENALTY COMPARED BEST SiGe/GaP TO DATE, FROM GE-DATA, IS 2% LOWER n-TYPE SiGe/GaP ON 2 OR 3 SAMPLES AFTER ANNEALING

TO CURRENT DESIGN STUDIES

ISSUE #11: MODULE GLASSING

FUNCTION: ELECTRICAL ISOLATION, STRUCTURAL "GLUE" AND VAPOR SUPPRESSION

REQUIREMENTS:

LOW VAPOR PRESSURE SOFTENING AND RECRYSTALIZATION PROPERTIES CONSISTENT WITH ASSEMBLY CHEMICAL STABILTY UNDER OPERATING VOLTAGES AND TEMPERATURES

IMPERMEABLE TO Si, Ge, P, B (AND Ga, FOR FLIGHT)

IMPACT:

CLOSE-PACKED DEVICE COMPACT NOT VIABLE WITHOUT SOME SOLUTION

STATUS:

NATIONAL PANEL STUDIED THE FAILURES ELECTRICAL FAILURES IN MULTICOUPLES OBSERVED IN 1986 (MOD-RTG)

ONE MOD-RTG DEVICE BUILT WITH NO GAP FAILED IN AN ENTIRELY NO CONCENSUS YET EXISTS ON DETAILED FAILURE MECHANISM CURRENT MOD-RTG EE2/EE9 GLASS-SiGe/GaP SYSTEM NOT ACCEPTABLE DIFFERENT MANNER AND ONLY AFTER MUCH MORE SEVERE TESTING

POSSIBLE "FIXES" BEING IMPLEMENTED

SP-100 ENVIRONMENT IS DIFFERENT:

VOLTAGE ENVIRONMENT IS LESS SEVERE ON GLASSES

GEOMETRY LESS SENSITIVE TO SINGLE POINT FAILURES

GES DOES NOT USE Sige/GaP (BUT FLIGHT SYSTEM DOES)

REQUIREMENTS: FUNCTION: COMPLETE THE ELECTRICAL PATH TO THE THERMOELECTRICS ISSUE #12: JOINING OF ELECTRODE TO T/E MATERIALS, COLD SIDE

LOW ELECTRICAL CONTACT RESISTANCE

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS (EG. GLASS,

SURFICIENT MECHANICAL STRENGTH
SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

IMPACT:

LESS POWER OUTPUT

STATUS:

EXISTING SIMO TECHNOLOGY CAN BE READILY ADAPTED TO SP-100 CONTACT RESISTANCE IS MORE IMPORTANT TO SP-100 THAN RTG'S EXISTING TEST METHODS ARE INADEQUATE TO DETERMINE CONTACT SHORTER LEGS MAKE ELECTRODES A LARGER FRACTION OF TOTAL LOSS PERFORMANCE PENALTY NOT WELL KNOWN

RESISTANCE WITH ACCURACY REQUIRED BY SP-100 PLANS EXIST TO IMPROVE TEST METHODS

PLANS EXIST TO IMPROVE TEST METHODS
BASELINE COLD SIDE ELECTRODE IS TUNGSTEN

JOINING TECHNIQUES MUST BE ADVANCED

ISSUE #13: COLD SIDE ELECTRODE MATERIAL

FUNCTION: COMPLETE THE ELECTRICAL CIRCUIT BETWEEN LEGS

REQUIREMENTS:

THERMAL EXPANSION MATCH TO SiGe

HIGH THERMAL CONDUCTIVITY

LOW ELECTRICAL RESISTIVITY

JOINABLE TO SIGE WITH LOW SPECIFIC CONTACT RESISTANCE CHEMICAL COMPATIBILITY

JOINABLE TO CELL-TO-CELL INTERCONNECTION STRAP JOINABLE TO LOW VOLTAGE INSULATOR

SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

IMPACT:

LESS POWER OUTPUT

STATUS

EXISTING SIMO TECHNOLOGY CAN BE READILY ADAPTED TO SP-100 ELECTRODE PERFORMANCE IS MORE IMPORTANT TO SP-100 THAN RT SHORTER LEGS MAKE ELECTRODES A LARGER FRACTION OF TO PERFORMANCE PENALTY CONSIDERED LARGE

EXPERIENCE WITH TUNGSTEN INDICATED FAILURES DUE TO WSi FO TUNGSTEN IDENTIFIED AS PRIME CANDIDATE LOW ELECTRICAL RESISTIVITY, HIGH THERMAL CONDUCTIVIT OK AT LOWER TEMPERATURES, SP-100 OPERATES HOTTER

ISSUE #14 CELL TO CELL ELECTRICAL STRAP

FUNCTION: COMPLETE SYSTEM ELECTRICAL CIRCUIT BETWEEN CELLS

REQUIREMENTS:

LOW ELECTRICAL RESISTANCE

JOINABLE TO COLD SIDE ELECTRODE MATERIAL CHEMICALLY COMPATIBLE WITH COLD SIDE ELECTRODE MATERIAL TRANSMIT SMALL FORCES BACK INTO CELL FIT IN A SPACE 0.05" WIDE SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

SOME FAILURES COULD CAUSE POWER LOSS FROM LARGE STRINGS OF CELLS COMPLICATES ASSEMBLY PROCEEDURES

DESIGN WORK ON TUNGSTEN STRAPS INITIATED STRAP AND ATTACHMENT TECHNIQUES NOT IDENTIFIED COLD SIDE ELECTRODE MATERIALS FOR ALTERNATE

CHAPT 21

ISSUE #15: JOINING OF ELECTRODE TO LOW VOLTAGE INSULATOR, COLD SIDE FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS

SUFFICIENT MECHANICAL STRENGTH

SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

CLOSE PACKED DEVICE CONCEPT FAILS WITHOUT FUNCTIONAL LOW VOLTAGE INSULATOR AND JOINING TECHNOLOGY IMPACT:

EXISTING GLASSES (NOT EE2/EE9) HAVE BEEN BONDED TO TUNGSTEN BUT ARE NOT SUITABLE TO SP-100 OPERATING TEMPERATURES

BONDING TECHNOLOGY DEPENDS ON CHOICE OF ELECTRODE MATERIAL

FUNCTION: ELECTRICALLY ISOLATE A MODULE FROM COMPLIANT PAD ISSUE #16 COLD SIDE LOW VOLTAGE INSULATOR

REQUIREMENTS:

SIMILAR TO HOT INSULATOR BUT LESS SEVERE DUE TO LOWER TEMPERATURE THERMAL EXPANSION MATCH

HIGH ELECTRICAL RESISTIVITY (R) TO MINIMIZE ELECTRICAL POWER LOSS FIGURE OF MERIT = R*K, 300 V^2/K IS PROBABLY ACCEPTABLE HIGH THERMAL CONDUCTIVITY (K) TO MINIMIZE TEMPERATURE DROP

CHEMICAL COMPATIBILITY (THERMODYNAMIC)

STABILITY IN MODERATE ELECTRIC FIELD (200 V/cm)

JOINABLE TO COMPLIANT PAD AND ELECTRODES SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

IMPACT:

STATUS:

MODULES LOSE POWER IF GLASS FAILS

FOR THIS APPLICATION, EXISTING GLASS SHOULD BE ADEQUATE EE2/EE9 GLASS IDENTIFIED IDENTICAL GLASS USED FOR MODULE GLASSING

ISSUE #17: JOINING OF LOW VOLTAGE INSULATOR TO COMPLIANT PAD, COLD SIDE FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS SUFFICIENT MECHANICAL STRENGTH

MUST BE EFFECTED WITHOUT CRUSHING COMPLIANT PAD SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMEPRATURES

I MP ACT:

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

STATUS:

EXPECT TO REQUIRE METALLIZATION OF LOW VOLTAGE INSULATOR

ISSUE #18: COMPLIANT PAD, COLD SIDE

FUNCTION: ACCOMODATE ACCOMODATE THERMAL EXPANSION BETWEEN PRIMARY HEAT LOOP, TRANSMITED THROUGH CELL, AND HEAT REJECTION SYSTEM LOOP

REQUIREMENTS:

MECHANICAL INTEGRITY

HIGH THERMAL CONDUCTIVITY

TRANSMITS SMALL FORCES INTO THERMOELECTRIC MODULE

INTERNAL CHEMICAL COMPATIBILITY

SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMEPRATURES JOINABLE TO HIGH AND LOW VOLTAGE INSULATOR

IMPACT: SYSTEM PERFORMANCE IS STRONGLY DRIVEN BY PAD PERFORMANCE CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL PAD

STATUS:

INITIAL DEVELOPMENT UNDER IRD RESULTED IN TEST MODULE POOR THERMAL PERFORMANCE

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ISSUE #18: COMPLIANT PAD, COLD SIDE

FUNCTION: ACCOMODATE THERMAL EXPANSION BETWEEN PRIMARY HEAT LOOP, TRANSMITED THROUGH CELL, AND HEAT REJECTION SYSTEM LOOP

REQUIREMENTS:

MECHANICAL INTEGRITY

HIGH THERMAL CONDUCTIVITY

TRANSMITS SMALL FORCES INTO THERMOELECTRIC MODULE

INTERNAL CHEMICAL COMPATIBILITY
JOINABLE TO HIGH AND LOW VOLTAGE INSULATOR

SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMEPRATURES

IMPACT: CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL PAD

STATUS:

INITIAL DEVELOPMENT UNDER IRD RESULTED IN TEST MODULE SYSTEM PERFORMANCE IS STRONGLY DRIVEN BY PAD PERFORMANCE MANY FIBERS BROKEN POOR THERMAL PERFORMANCE

ACCEPTABLE PAD HAS NOT BEEN DEMONSTRATED

FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE ISSUE #19: JOINING OF COMPLIANT PAD TO INSULATOR, COLD SIDE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE NOT TOO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS

SUFFICIENT MECHANICAL STRENGTH

MUST BE EFFECTED WITHOUT CRUSHING COMPLIANT PAD SURVIVE SHORT TERM EXCURSIONS TO HIGH TEMPERATURES

IMPACT:

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

STATUS:

EXPECT TO REQUIRE METALLIZED INSULATOR

HART 26

FUNCTION: ELECTRICALLY ISOLATE EACH CELL FROM COMMON STRUCTURAL ELEMENTS ISSUE #20: COLD SIDE HIGH VOLTAGE ELECTRICAL INSULATOR REQUIREMENTS:

THERMAL EXPANSION MATCH

HIGH ELECTRICAL RESISTIVITY (R) TO MINIMIZE ELECTRICAL POWER LOSS FIGURE OF MERIT = R*K, GOAL OF 2,000,000 V^2/K HIGH THERMAL CONDUCTIVITY (K) TO MINIMIZE TEMPERATURE DROP

CHEMICAL COMPATIBILITY (THERMODYNAMIC)

STABILITY IN HIGH ELECTRIC FIELD (4000 V/cm)
JOINABLE TO HEAT REJECTION SYSTEM AND COMPLIANT PAD

SURVIVE SHORT EXCURSIONS TO HIGH TEMPERATURES

IMPACT:

SYSTEM PERFORMANCE IS DIRECTLY RELATED TO INSULATOR F.O.M. CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL INSULATOR

STATUS:

CONFIDENCE IS QUITE HIGH THAT A1203, IN SOME FORM, LOWER TEMPERATURE MAKES ALL THE DIFFERENCE S SATISFACTORY

ISSUE #21: JOINING COLD SIDE ELECTRICAL INSULATOR TO HEAT REJECTION SYST FUNCTION: COMPLETE THE HEAT PATH TO THE MODULE

REQUIREMENTS:

HIGH THERMAL CONDUCTIVITY

NOT TO HOT TO DAMAGE MATERIALS OR PREVIOUSLY MADE BONDS HOT ENOUGH TO BE STABLE FOR YEARS AT OPERATION TEMPERATURE

SUFFICIENT MECHANICAL STRENGTH

CHEMICAL COMPATIBILITY WITH INSULATOR AND Nb1Zr

IMPACT:

CONDUCTIVELY COUPLED CONCEPT FAILS WITHOUT FUNCTIONAL JOINT

STATUS:

SIMILAR BONDS HAVE BEEN EFFECTED EXISTING TECHNOLOGY CAN BE ADAPTED TO SP-100 WITH HIGH CONFIDENCE